



CofC

Docket No. 740819-501

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re PATENT application of Yoshihisa NAGANO et al.)
Patent No 6,847,074 B2) Serial No. 09/785,502
Issued: January 25, 2005) Art Unit: 2815
Filed: February 20, 2001) Examiner: E. J. Wojciechowicz
For: SEMICONDUCTOR MEMORY DEVICE) Confirmation No. 6527

REQUEST FOR CERTIFICATE OF CORRECTION

Commissioner for Patents
Alexandria, VA 22313-1450
Sir:

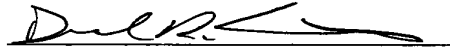
In reviewing the above-identified patent, printing errors were discovered therein requiring correction in order to conform the Official Record in the application.

The errors noted are set forth on the attached copy of Form PTO-1050 (Rev. 3-82) in the manner required by the Commissioner's Notice. Specifically, upon reviewing the front page of the patent, it was noted that in the claims, claim 3, column 8, line 67, "TaA1N Ti" should read "TaA1N, Ti.", claim 5, column 9, line 9, "electrode in contact with the contact with the contact plug" should read "electrode in contact with the contact plug.", claim 5, column 9, line 10, "plug, a film second film" should read "plug, second film.", claim 6, column 10, line 3, "the first first film" should read "the first film.", claim 7, column 10, line 10, TaA1N Ti" should read "TaA1N, Ti." and claim 8, column 10, line 11, "claim 6 wherein" should read "claim 6, wherein."

Certificate
SEP 26 2005
of Correction

The change requested herein occurred as a result of printing the Letters Patent and the Certificate should be issued without expense under Rule 322 of the Rules of Practice. Accordingly, applicants request issuance of the Certificate of Correction.

Respectfully submitted,



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UNITED STATES PATENT AND TRADEMARK OFFICE

CERTIFICATE OF CORRECTION

PATENT NO : 6,847,074 B2

DATED : January 25, 2005

INVENTOR(S) : Yoshihisa NAGANO et al.

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Claim 3, column 8, line 67, "TaA1N Ti" should read "TaA1N, Ti."

Claim 5, column 9, line 9, "electrode in contact with the contact with the contact plug" should read "electrode in contact with the contact plug."

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MAILING ADDRESS OF SENDER:

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